Notice of References Cited Application/Control No. 10/662,874 Examiner Sophia S. Chen Applicant(s)/Patent Under Reexamination ICHIKAWA ET AL. Page 1 of 1

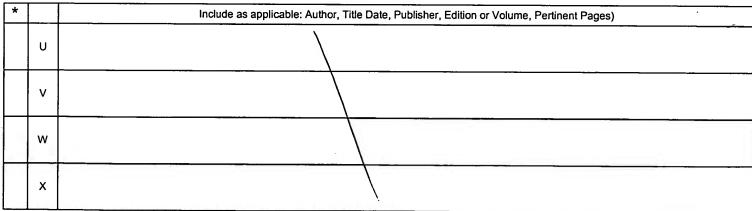
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,636,711 B1	10-2003	Katahira, Shunsuke	399/82
	В	US-6,763,202 B2	07-2004	Maeda, Yuichiro	399/53
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-	,	-	
	М	US-	1		

FOREIGN PATENT DOCUMENTS

TORCION FAILNI DOCUMENTS										
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification				
	N		(
	0									
	Р					·				
	Q									
	R									
	s		1							
	Т									

NON-PATENT DOCUMENTS



*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.